

Sophisticated Instrument Centre (SIC)
Field Emission Scanning Electron Microscope Facility (FE-SEM)
Indian Institute of Technology Indore

Instrument: *Field Emission Scanning Electron Microscope, Carl Zeiss Supra 55,*

Job requisition form

Name of the User		Roll no:
		I.D No.
B.Tech Ph.D Project Faculty Staff Industry Others (please specify)		
Contact Email	Phone (Internal)	Mobile
Section	Discipline	Laboratory
Guide/coordinator/ Supervisor name	Name	Email-id:
Sample details (Max 4) in one lot		
Nature of sample (<i>kindly intimate if toxic</i>)	Conductive /Non conductive	Number of samples
Description of the requirement (<i>please tick one</i>)		SEM/EDX/WDX
EDX/WDX		
Expected Elements		

Use of Field-Emission Scanning Electron Microscope (FE-SEM), Facility at IIT Indore automatically implies that following acknowledgement will be given by the user whenever either oral or written presentations are made of the results obtained from the facility:

“We are grateful to the **Field-Emission Scanning Electron Microscope (FE-SEM) Facility equipped at Sophisticated Instrument Centre (SIC), IIT Indore.**” Further, the user must ensure to send us copies of reprints of publications which contain results obtained from above facility.

Signature of Guide/Coordinator/Supervisor/User
Date